

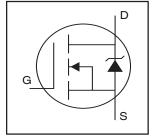
AUTOMOTIVE GRADE

AUIRF1324

HEXFET® Power MOSFET

Features

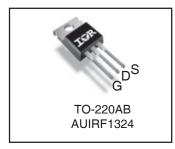
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}	24V
R _{DS(on)} typ.	1.2m Ω
max.	1.5m Ω
I _{D (Silicon Limited)}	353A①
I _{D (Package Limited)}	195A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	353 ①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	249 ①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	195	7 ^
I _{DM}	Pulsed Drain Current ②	1412	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ③	270	mJ
I _{AR}	Avalanche Current ②	See Fig. 14, 15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ③		mJ
dv/dt	Peak Diode Recovery @	0.46	V/ns
T_J	Operating Junction and	FF 4 17F	
T _{STG}	Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

Thermal Resistance

THOTHAI TEOLOGICA								
Symbol	Parameter	Тур.	Max.	Units				
$R_{\theta JC}$	Junction-to-Case ®		0.50					
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.50		°C/W				
$R_{\theta JA}$	Junction-to-Ambient		62					

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	24	_		V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		22		mV/°C	Reference to 25°C, I _D = 5.0mA ^②
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.2	1.5	mΩ	V _{GS} = 10V, I _D = 195A ③
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	180			S	$V_{DS} = 10V, I_{D} = 195A$
R_G	Internal Gate Resistance		2.3		Ω	
I _{DSS}	Drain-to-Source Leakage Current		_	20	μA	$V_{DS} = 24V, V_{GS} = 0V$
				250		$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-200	Ī	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

_	· ·	•			•	•
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		160	240		$I_D = 195A$
Q_{gs}	Gate-to-Source Charge		84		nC	$V_{DS} = 12V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		49		IIC	V _{GS} = 10V ③
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		76		Ĭ	$I_D = 195A, V_{DS} = 0V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		17			$V_{DD} = 16V$
t _r	Rise Time		190			$I_D = 195A$
t _{d(off)}	Turn-Off Delay Time		83		ns	$R_G = 2.7\Omega$
t _f	Fall Time		120			V _{GS} = 10V ③
C _{iss}	Input Capacitance		7590			$V_{GS} = 0V$
C _{oss}	Output Capacitance		3440		İ	$V_{DS} = 24V$
C _{rss}	Reverse Transfer Capacitance		1960		рF	f = 1.0 MHz, See Fig. 5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		4700			$V_{GS} = 0V$, $V_{DS} = 0V$ to 19V \bigcirc , See Fig. 11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		4490			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 19V $

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			353①		MOSFET symbol	
	(Body Diode)			333⊕	Α	showing the	
I _{SM}	Pulsed Source Current			1412		integral reverse	
	(Body Diode) ②			1412		p-n junction diode.	
V_{SD}	Diode Forward Voltage		-	1.3	V	$T_J = 25^{\circ}C$, $I_S = 195A$, $V_{GS} = 0V$ \odot	
t _{rr}	Reverse Recovery Time		46	_	no	$T_J = 25^{\circ}C$ $V_R = 20V$,	
			71		ns	$T_J = 125^{\circ}C$ $I_F = 195A$	
Q _{rr}	Reverse Recovery Charge		160		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ μ s \odot	
			430		IIC	$T_{J} = 125^{\circ}C$	
I _{RRM}	Reverse Recovery Current		7.7		Α	$T_J = 25^{\circ}C$	
t _{on}	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 195A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\mbox{\@ifnextcoloredge}$ Limited by $T_{Jmax},$ starting $T_J=25^{\circ}C,\,L=0.014mH$ $R_G=25\Omega,\,I_{AS}=195A,\,V_{GS}=10V.$ Part not recommended for use above this value .
- $\textcircled{4} \quad I_{SD} \leq 195 A, \ di/dt \leq 450 \ A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_{J} \leq 175^{\circ}C.$

- $^{\circ}$ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- $\ensuremath{\$}\ R_{\theta}$ is measured at T_J approximately 90°C

Qualification Information[†]

		Automotive				
		(per AEC-Q101) ^{††}				
IR's			Comments: This part number(s) passed Automotive qualification. R's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		D2Pak	MSL1			
			N/A			
	Machine Model	Class M4				
		AEC-Q101-002				
505	Human Body Model	Class H3A				
ESD			AEC-Q101-001			
	Charged Device Model	Class C5				
		AEC-Q101-005				
RoHS Compli	iant		Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.

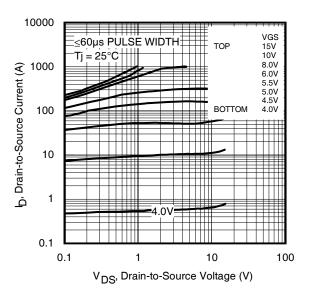


Fig 1. Typical Output Characteristics

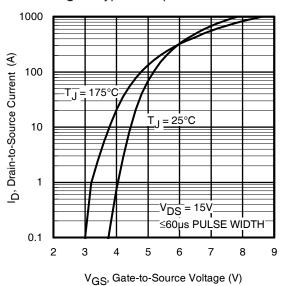


Fig 3. Typical Transfer Characteristics

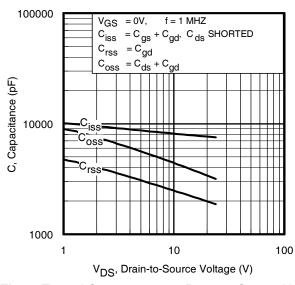


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

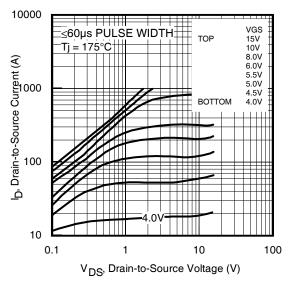


Fig 2. Typical Output Characteristics

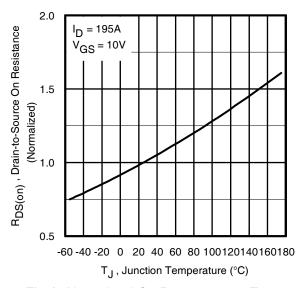


Fig 4. Normalized On-Resistance vs. Temperature

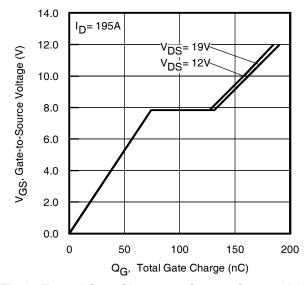


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

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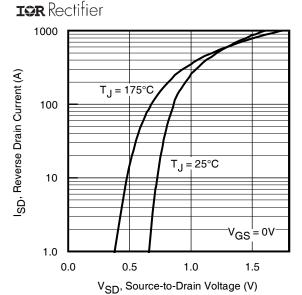
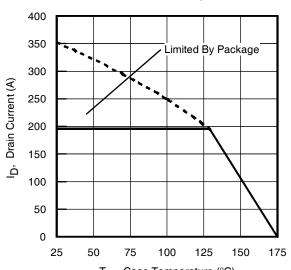
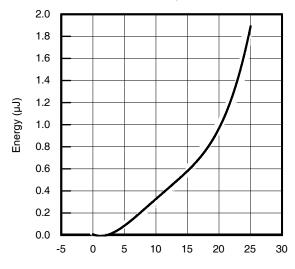


Fig 7. Typical Source-Drain Diode Forward Voltage



T_C , Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} V_{DS,} \mbox{ Drain-to-Source Voltage (V)}$ **Fig 11.** Typical C_{OSS} Stored Energy

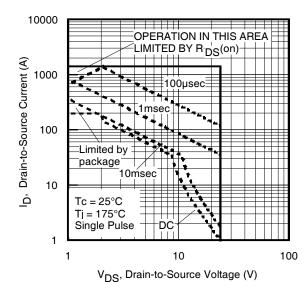


Fig 8. Maximum Safe Operating Area

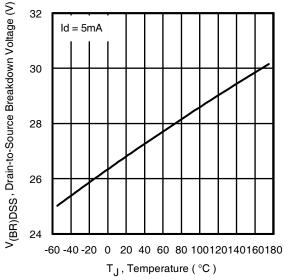


Fig 10. Drain-to-Source Breakdown Voltage

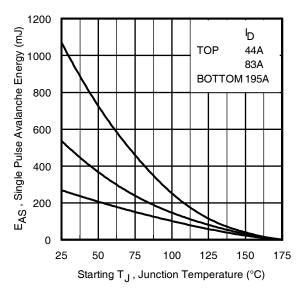


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

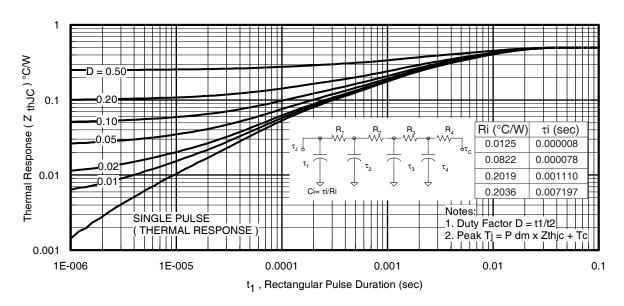
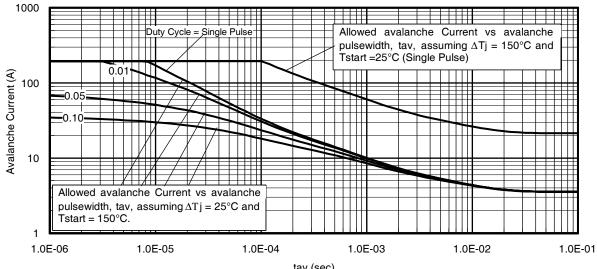


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



tav (sec)

Fig 14. Typical Avalanche Current vs.Pulsewidth

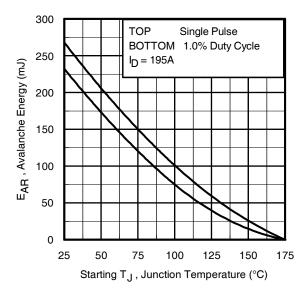


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

 t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3 \cdot BV \cdot I_{av}) = \triangle T/~Z_{thJC} \\ I_{av} &= 2\triangle T/~[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS~(AR)} &= P_{D~(ave)} \cdot t_{av} \end{split}$$

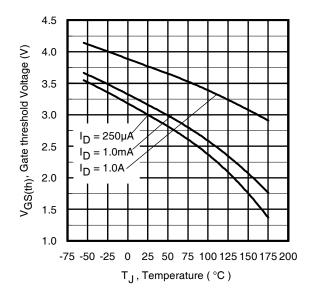
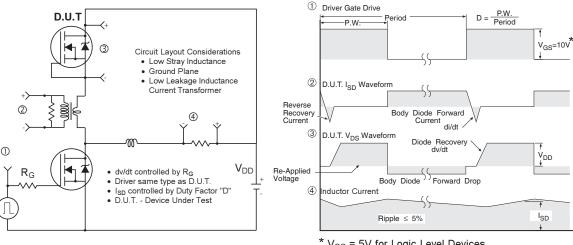


Fig 16. Threshold Voltage vs. Temperature



* V_{GS} = 5V for Logic Level Devices

Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

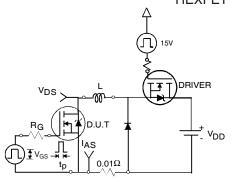


Fig 22a. Unclamped Inductive Test Circuit

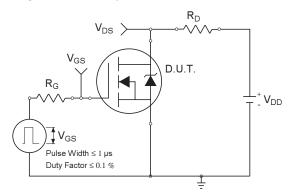


Fig 23a. Switching Time Test Circuit

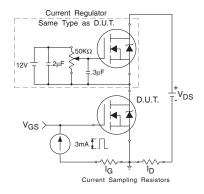


Fig 24a. Gate Charge Test Circuit

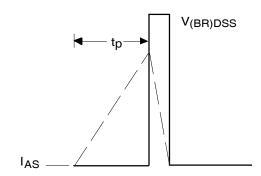


Fig 22b. Unclamped Inductive Waveforms

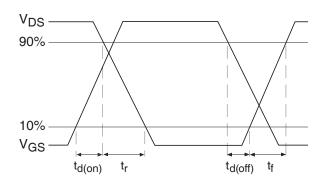


Fig 23b. Switching Time Waveforms

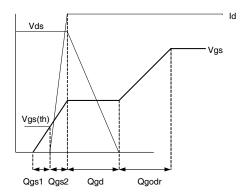
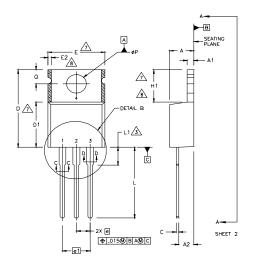
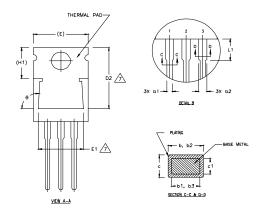


Fig 24b. Gate Charge Waveform

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS], LEAD DIMENSION AND FINISH UNCONTROLLED IN L1
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH
 SHALL NOT EXCEED .005" (0,127) PER SIDE, THESE DIMENSIONS ARE
 MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY,
- DIMENSION b1 & c1 APPLY TO BASE METAL ONLY, CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING

0	DIMEN	DIVIN	LZ	A L	11	DELIME	. н	ZUI	4E ¥	UEKE.	SIAN
	AND	SING	ULA.	TION	ΙR	REGULA	ARIT	IES	ARE	ALL0	WED.

LEAD ASSIGNMENTS

HEXFET

IGBTs, CoPACK

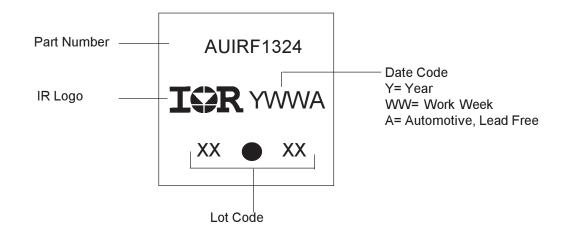
- 1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

- 1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.82	.140	.190	
A1	0.51	1.40	.020	.055	
A2	2.04	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.96	.015	.038	5
b2	1.15	1.77	.045	.070	
b3	1.15	1.73	.045	.068	
c	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
e	2.54 5,1		,100	BSC BSC	
e1					
H1	5.85	6.55	.230	.270	7,8
L	12.70	14.73	.500	.580	_
L1	-	6.35	-	.250	3
ØΡ	3.54	4.08	,139	.161	
Q	2,54	3,42	,100	.135	
ø	90°-	-95	90*-	-93'	

TO-220AB Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
-	5 7.	Form	Quantity	-
AUIRF1324	TO-220	Tube	50	AUIRF1324



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